

Technology & Industry Alliances Available Technologies Contact Us

Request Information Permalink

This technology is currently not available for licensing

Tech ID: 24139

ADDITIONAL TECHNOLOGIES BY THESE INVENTORS

- ► High-Quality N-Face GaN, InN, AIN by MOCVD
- ▶ Defect Reduction in GaN films using in-situ SiNx Nanomask
- ► A Structure For Increasing Mobility In A High-Electron-Mobility Transistor
- ▶ Improved Fabrication of Nonpolar InGaN Thin Films, Heterostructures, and Devices
- ▶ Methods for Locally Changing the Electric Field Distribution in Electron Devices
- ▶ Technique for the Nitride Growth of Semipolar Thin Films, Heterostructures, and Semiconductor Devices
- ► (In,Ga,AI)N Optoelectronic Devices with Thicker Active Layers for Improved Performance
- ► GaN-based Vertical Metal Oxide Semiconductor and Junction Field Effect Transistors
- Novel Current-Blocking Layer in High-Power Current Aperture Vertical Electron Transistors (CAVETs)
- ▶ Iii-N Transistor With Stepped Cap Layers
- ▶ III-N Based Material Structures and Circuit Modules Based on Strain Management





in

© 2014 - 2015, The Regents of the University of California

Terms of use

Privacy Notice